

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/825,904	DAO ET AL.	
Examiner	Art Unit	_
Christopher B. Shin	2181	

SEARCHED					
Class	Subclass	Date	Examiner		
710	8-19 34- 38, 43-46, 62-64	6/12/2006	CBS		
710	72-74	6/12/2006	CBS		
710	316	6/12/2006	CBS		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
710	8,38,316	8/20/2006	CBS		
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
PLUS	6/12/2006	CBS
PALM (Double patenting/Inventors)	6/12/2006	CBS
EAST (EPO, JPO, USPAT, USPGPUB, IBMTDB, USOCR)	6/12/2006	CBS
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